

Search Notes

Application/Control No.

10/774,827

Examiner

Michael Trinh

Applicant(s)/Patent under
Reexamination

WEIS ET AL.

Art Unit

2822

SEARCHED

Class	Subclass	Date	Examiner
257	Updated previous subclasses	5/31/2006	MT

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR